

# LINEAR SYSTEMS

Twenty-Five Years Of Quality Through Innovation

## SST/U401 – SST/U406

LOW NOISE LOW DRIFT  
MONOLITHIC DUAL N-CHANNEL  
JFET AMPLIFIER

### FEATURES

LOW DRIFT	$ V_{GS1-2}/T  = 10\mu V/{^\circ}C$ TYP.
LOW NOISE	$e_n=6nV/Hz @ 10Hz$ TYP.
LOW PINCHOFF	$V_P=2.5V$ MAX.

### ABSOLUTE MAXIMUM RATINGS NOTE 1

@ 25 °C (unless otherwise noted)

### Maximum Temperatures

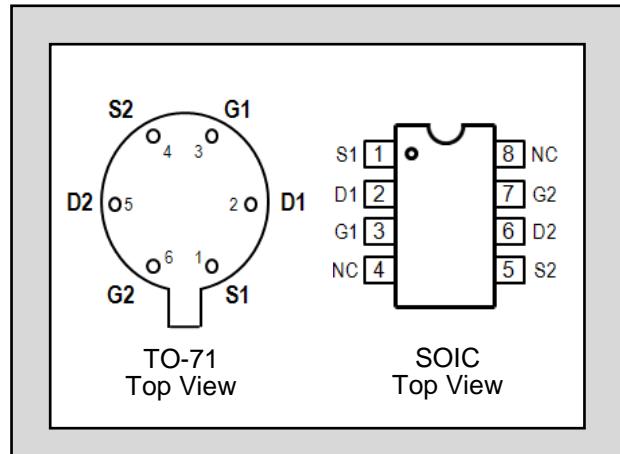
Storage Temperature	-55 to +150°C
Operating Junction Temperature	-55 to +150°C

### Maximum Voltage and Current for Each Transistor NOTE 1

-V <sub>GSS</sub>	Gate Voltage to Drain or Source	50V
-V <sub>DSO</sub>	Drain to Source Voltage	50V
-I <sub>G(f)</sub>	Gate Forward Current	10mA

### Maximum Power Dissipation per side NOTE 2

Device Dissipation TA = 25°C      300mW



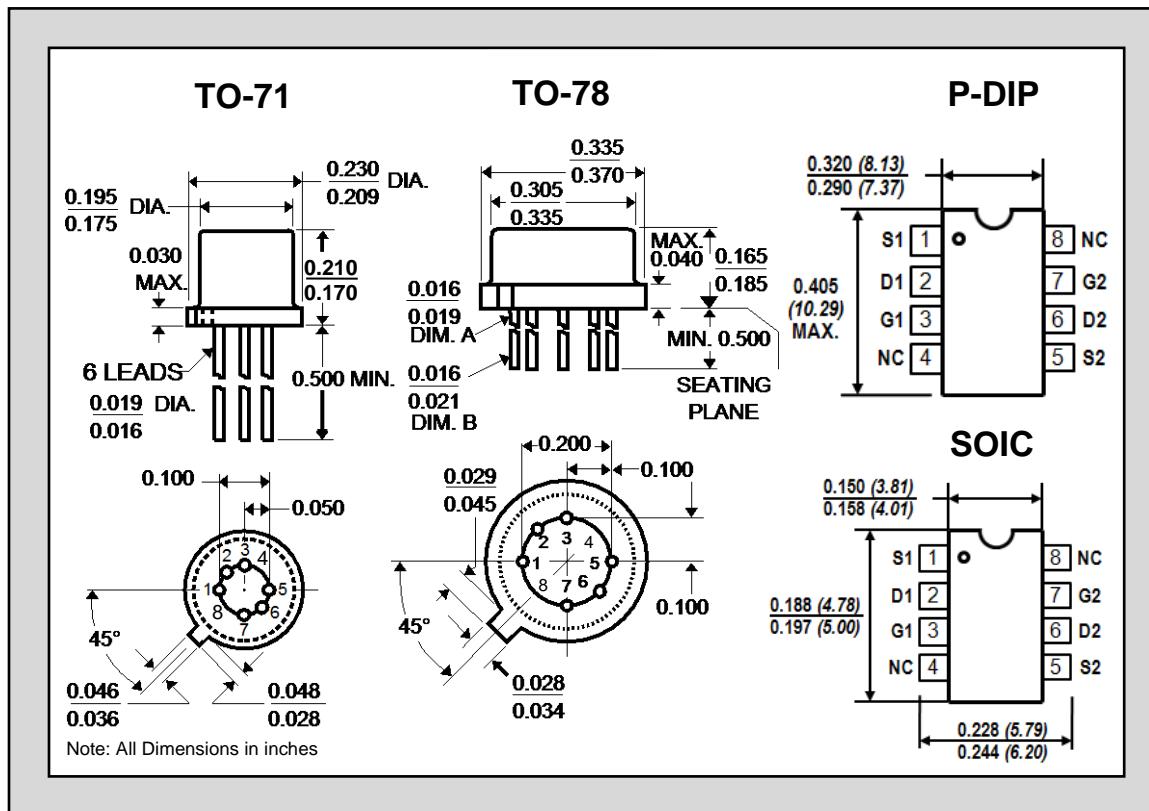
### MATCHING CHARACTERISTICS @ 25°C (unless otherwise noted)

SYMBOL	CHARACTERISTIC	U401	U402	U403	U404	U405	U406	UNITS	CONDITIONS
$ V_{GS1-2}/T $ max.	Drift vs. Temperature	10	10	25	25	40	80	$\mu V/{^\circ}C$	$V_{DG}=10V, I_D=200\mu A$ $T_A=-55^{\circ}C$ to $+125^{\circ}C$
$ V_{GS1-2} $ max.	Offset Voltage	5	10	10	15	20	40	mV	$V_{DG}=10V, I_D=200\mu A$

### ELECTRICAL CHARACTERISTICS TA = 25°C (unless otherwise noted) NOTE 3

SYMBOL	CHARACTERISTIC	MIN.	TYP.	MAX.	UNITS	CONDITIONS
BV <sub>GSS</sub>	Breakdown Voltage	-50	-60	--	V	$V_{DS}=0$ $I_D=1nA$
BV <sub>G1G2</sub>	Gate-to-Gate Breakdown	$\pm 50$	--	--	V	$I_G=\pm 1\mu A$ $I_D=0, I_S=0$
<u>G<sub>fs</sub></u>	<u>TRANSCONDUCTANCE</u>					
G <sub>fs</sub>	Full Conduction	2000	--	7000	$\mu S$	$V_{DG}=10V$ $V_{GS}=0$ f = 1kHz
G <sub>fs</sub>	Typical Operation	1000	--	2000	$\mu S$	$V_{DG}=15V$ $I_D=200\mu A$ f = 1kHz
$ G_{f1}/G_{f2} $	Mismatch	0.97	--	1.0		
ID <sub>SS</sub>	Saturation Drain Current	0.5	--	10	mA	
$ ID_{SS1}/ID_{SS2} $	Saturation Current Ratio	0.9	0.98	1.0		$V_{DG}=10V$ $V_{GS}=0$
<u>GATE VOLTAGE</u>						
V <sub>GS(off)</sub> or V <sub>P</sub>	Pinchoff Voltage	-0.5	--	-2.5	V	$V_{DS}=15V$ $I_D=1nA$
V <sub>GS</sub>	Operating Range	--	--	-2.3	V	$V_{DS}=15V$ $I_D=200\mu A$
<u>GATE CURRENT</u>						
I <sub>G</sub>	Operating	--	-4	-15	pA	$V_{DG}=15V$ $I_D=200\mu A$
I <sub>G</sub>	High Temperature	--	--	-10	nA	$T_A=+125^{\circ}C$
I <sub>GSS</sub>	Gate Reverse Current	--	--	-100	pA	$V_{GS}=-30V, V_{DS}=0V$
I <sub>G1G2</sub>	Gate to Gate Isolation Current	--	--	$\pm 1.0$	$\mu A$	$V_{G1}-V_{G2}=\pm 50V, I_D=IS=0$

SYMBOL	CHARACTERISTIC	MIN.	TYP.	MAX.	UNITS	CONDITIONS
Goss	<u>OUTPUT CONDUCTANCE</u> Full Conduction	--	--	40	μS	V <sub>DS</sub> = 10V, V <sub>GS</sub> = 0V, f = 1kHz
Gos	Operating	--	2	2.7	μS	V <sub>DS</sub> = 15V, I <sub>D</sub> = 200μA, f = 1kHz
CMRR	<u>COMMON MODE REJECTION</u> -20 log [(V <sub>GS1</sub> -V <sub>GS2</sub> )/ΔV <sub>DG1-2</sub> ]	95	--	--	dB	V <sub>DG1</sub> = 10V V <sub>DG2</sub> = 20V I <sub>D1</sub> = I <sub>D2</sub> =200μA
NF	<u>NOISE</u> Figure	--	--	0.5	dB	V <sub>DS</sub> = 15V V <sub>GS</sub> = 0 R <sub>G</sub> =10M f= 100Hz NBW= 6Hz
e <sub>n</sub>	Voltage	--	6	20	nV/Hz	V <sub>DS</sub> = 15V I <sub>D</sub> = 200μA f= 10Hz NBW= 1Hz
C <sub>ISS</sub>	<u>CAPACITANCE</u> Input	--	4	8	pF	V <sub>DS</sub> = 15V I <sub>D</sub> = 200μA f= 1MHz
C <sub>RSS</sub>	Reverse Transfer	--	1.5	3	pF	



### NOTES:

- These ratings are limiting values above which the serviceability of any semiconductor may be impaired.
- Derate 2.4mW/°C when TA is greater than 25°C
- All MIN/TYP/MAX limits are absolute numbers. Negative signs indicate electrical polarity only.

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